Preferred Device

Triacs

Silicon Bidirectional Thyristors

Designed for high performance full-wave ac control applications where high noise immunity and high commutating di/dt are required.

- Blocking Voltage to 800 Volts
- On-State Current Rating of 15 Amperes RMS at 80°C
- Uniform Gate Trigger Currents in Three Modes
- High Immunity to dv/dt 250 V/µs minimum at 125°C
- Minimizes Snubber Networks for Protection
- Industry Standard TO-220AB Package
- High Commutating di/dt 9.0 A/ms minimum at 125°C
- Operational in Three Quadrants, Q1, Q2, and Q3
- Device Marking: Logo, Device Type, e.g., MAC15M, Date Code

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off–State Voltage ⁽¹⁾ (–40 to 125°C, Sine Wave, 50 to 60 Hz, Gate Open)	^V drm, ^V rrm		Volts
MAC15M MAC15N		600 800	
On–State RMS Current (Full Cycle Sine Wave, 60 Hz, T _C = 80°C)	^I T(RMS)	15	A
Peak Non-repetitive Surge Current (One Full Cycle Sine Wave, 60 Hz, T _J = 125°C)	ITSM	150	A
Circuit Fusing Consideration (t = 8.3 ms)	l ² t	93	A ² s
Peak Gate Power (Pulse Width \leq 1.0 μ s, T _C = 80°C)	PGM	20	Watts
Average Gate Power (t = 8.3 ms, $T_C = 80^{\circ}C$)	PG(AV)	0.5	Watts
Operating Junction Temperature Range	Тj	-40 to +125	°C
Storage Temperature Range	T _{stg}	−40 to +150	°C

(1) V_{DRM} and V_{RRM} for all types can be applied on a continuous basis. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

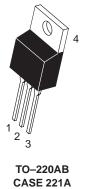


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TRIACS 15 AMPERES RMS 600 thru 800 VOLTS





CASE 221A STYLE 4

PIN ASSIGNMENT			
1	Main Terminal 1		
2	Main Terminal 2		
3	Gate		
4	Main Terminal 2		

ORDERING INFORMATION

Device	Package	Shipping
MAC15M	TO220AB	50 Units/Rail
MAC15N	TO220AB	50 Units/Rail

Preferred devices are recommended choices for future use and best overall value.

THERMAL CHARACTERISTICS

Symbol	Characteristic	Value	Unit
R _θ JC R _θ JA			°C/W
TL	Maximum Lead Temperature for Soldering Purposes 1/8" from Case for 10 Seconds	260	°C

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted; Electricals apply in both directions)

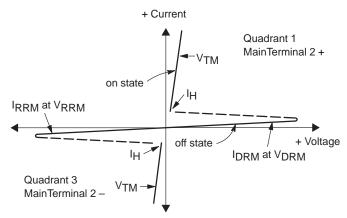
Symbol	Characteristic	Min	Тур	Max	Unit
OFF CH	ARACTERISTICS				
I _{DRM} , I _{RRM}	$ \begin{array}{l} \mbox{Peak Repetitive Blocking Current} \\ (V_D = Rated V_{DRM}, V_{RRM}; \mbox{Gate Open}) \\ T_J = 25^{\circ}C \\ T_J = 125^{\circ}C \end{array} $			0.01 2.0	mA
ON CHA	RACTERISTICS		-		
V _{TM}	Peak On-State Voltage(1) (I _{TM} = ±21 A Peak)	_	1.2	1.6	Volts
I _{GT}	Gate Trigger Current (Continuous DC) ($V_D = 12 V$, $R_L = 100 \Omega$) MT2(+), G(+) MT2(+), G(-) MT2(-), G(-)	5.0 5.0 5.0	13 16 18	35 35 35	mA
ΙΗ	Hold Current ($V_D = 12$ Vdc, Gate Open, Initiating Current = ±150 mA)	_	20	40	mA
ιL	Latching Current (V_D = 24 V, I _G = 35 mA) MT2(+), G(+) MT2(+), G(-) MT2(-), G(-)		33 36 33	50 80 50	mA
V _{GT}	Gate Trigger Voltage (V _D = 12 V, R _L = 100 Ω) MT2(+), G(+) MT2(+), G(-) MT2(-), G(-)	0.5 0.5 0.5	0.75 0.72 0.82	1.5 1.5 1.5	Volts
DYNAMI	C CHARACTERISTICS	•	•	•	•
(di/dt) _C	$ \begin{array}{l} \mbox{Rate of Change of Commutating Current; See Figure 10.} \\ \mbox{(V}_D = 400 \mbox{ V, } I_{TM} = 6.0 \mbox{ A, Commutating dv/dt} = 24 \mbox{ V/} \mu s, \qquad C_L = 10 \mu F \end{array} $	9.0	-	-	A/ms

(all al)C	$(V_D = 400 \text{ V}, \text{ I}_{TM} = 6.0 \text{ A}, \text{ Commutating dv/dt} = 24 \text{ V/}\mu\text{s}, \qquad C_L = 10 \mu\text{F}$ Gate Open, T _J = 125°C, f = 250 Hz, No Snubber) $L_L = 40 \text{ mH}$	0.0			7,1110
dv/dt	Critical Rate of Rise of Off-State Voltage (V _D = Rated V _{DRM} , Exponential Waveform, Gate Open, T _J = 125°C)	250	_	—	V/µs

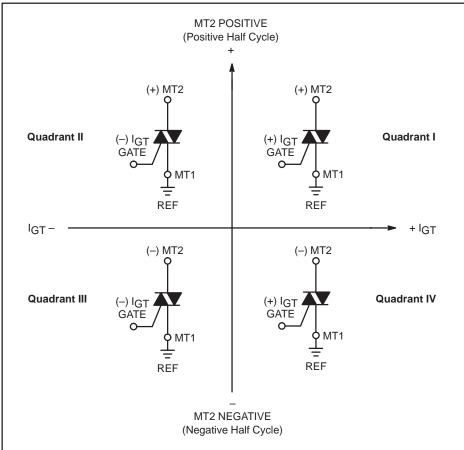
(1) Pulse Test: Pulse Width \leq 2.0 ms, Duty Cycle \leq 2%.

Voltage Current Characteristic of Triacs (Bidirectional Device)

Symbol	Parameter
VDRM	Peak Repetitive Forward Off State Voltage
IDRM	Peak Forward Blocking Current
VRRM	Peak Repetitive Reverse Off State Voltage
IRRM	Peak Reverse Blocking Current
VTM	Maximum On State Voltage
Ι _Η	Holding Current

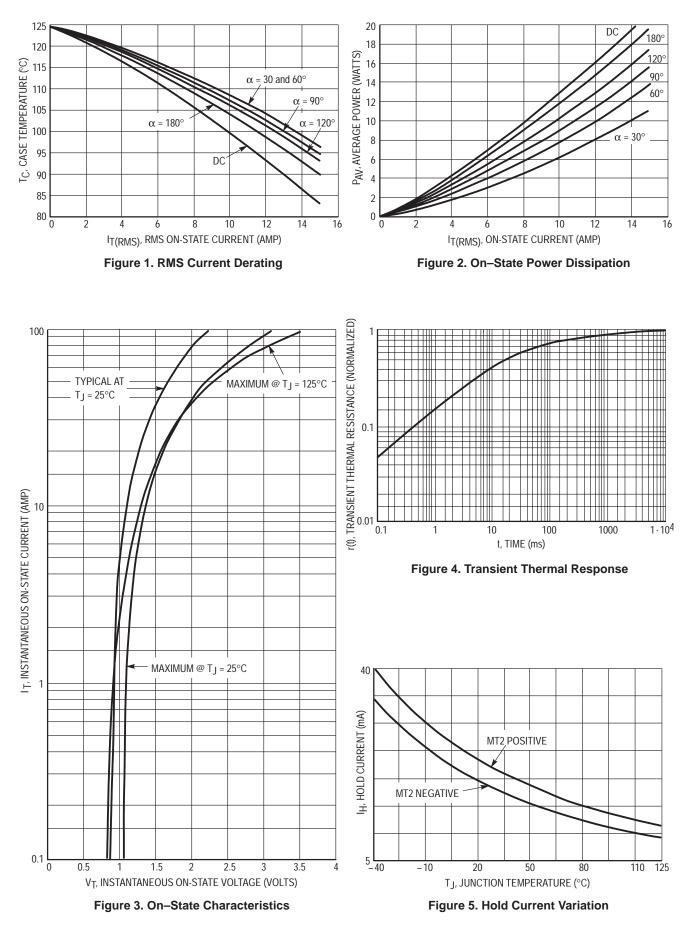


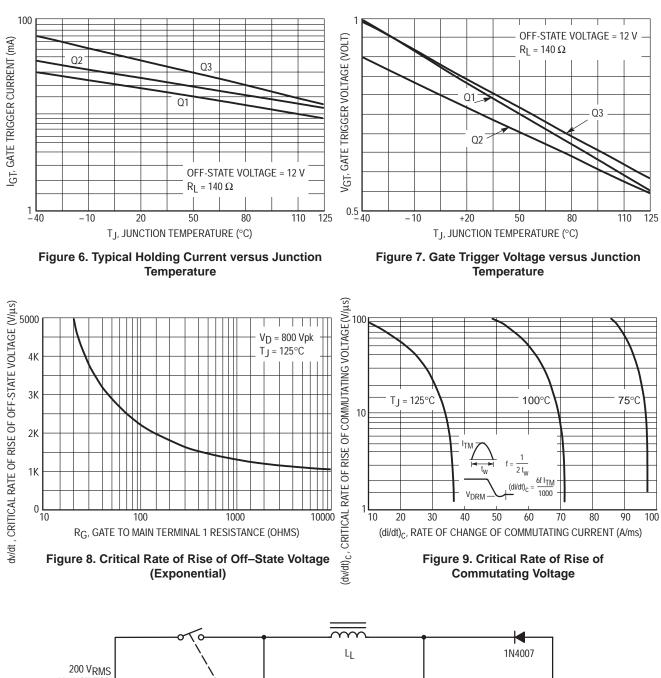


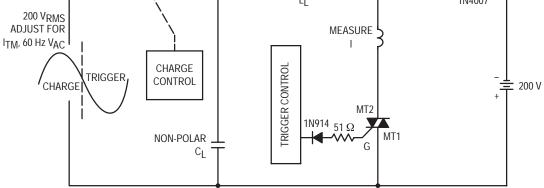


All polarities are referenced to MT1.

With in-phase signals (using standard AC lines) quadrants I and III are used.





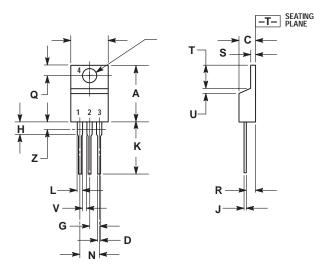


Note: Component values are for verification of rated (di/dt)_c. See AN1048 for additional information.

Figure 10. Simplified Test Circuit to Measure the Critical Rate of Rise of Commutating Current (di/dt)c

PACKAGE DIMENSIONS

TO-220AB CASE 221A-09 **ISSUE Z**



NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH. 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.570	0.620	14.48	15.75
В	0.380	0.405	9.66	10.28
С	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.42	2.66
Н	0.110	0.155	2.80	3.93
J	0.018	0.025	0.46	0.64
К	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
Ν	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
Т	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
V	0.045		1.15	
Ζ		0.080		2.04

STYLE 4: PIN 1. MAIN TERMINAL 1 2. MAIN TERMINAL 2 3. GATE 4. MAIN TERMINAL 2

Notes

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